Notice of References Cited

Application/Control No. 10/553,412	Applicant(s)/Pater Reexamination YAMAMICHI ET A	
Examiner	Art Unit	
Christian LaForgia	2439	Page 1 of 1

II S PATENT DOCUMENTS

	U.S. PATENT DOCUMENTS				
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,805,699 A	09-1998	Akiyama et al.	705/58
*	В	US-2002/0141737 A1	10-2002	Fuchigami, Norihiko	386/98
*	С	US-6,782,190 B1	08-2004	Morito, Hajime	386/94
*	D	US-2004/0190868 A1	09-2004	Nakano et al.	386/094
*	Е	US-7,149,754 B2	12-2006	Miller et al.	707/104.1
*	F	US-7,327,934 B2	02-2008	Kitani, Satoshi	386/94
*	G	US-2008/0069354 A1	03-2008	Kitani et al.	380/202
*	Н	US-2008/0072072 A1	03-2008	Muraki et al.	713/193
*	1	US-7,500,101 B2	03-2009	Kitani, Satoshi	713/169
*	J	US-2009/0202071 A1	08-2009	KATO, Taku	380/201
	К	US-			
	L	US-			
	м	US-			

FOREIGN PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS						
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 2004/053699	06-2004	JP	Kitani et al.	G06F 12/14
	0					
	Р					
	Q					
	R					
	s					
	т					

NON DATENT DOCUMENTS

*	NON-FAIENT DOCUMENTS			
_	\vdash	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
	U			
	v			
	w			
	x			

"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.